

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/679,333	HEPPER ET AL.	
Examiner	Art Unit .	
Benjamin E. Lanier	2132	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated Limited Search of 713/168,171,172,176 See Attachment	5/31/2006	B		
Updated East Search See Attachment	5/31/2006	B		
Interference Search See Attachment	5/31/2006	R		
Inventor Name Search Palm	5/31/2006	R		